

The **EMMC 2025 International Workshop** will take place 8-10 April 2025 at TU Vienna (Vienna, AT) <https://emmc.eu/emmc-2025/>

Themed **“Accelerated Innovation and Sustainability by a Materials Modelling and Data Ecosystem”**, it is the leading cross-cutting event in Europe, gathering stakeholders from different materials & digital fields in industry and academia.

It brings professionals, funders and policymakers to discuss topics of strategic importance and elaborate on gaps and potential actions to move the field forward.

The workshop will discuss these points from different perspectives including

- **Advancements in modelling and integration with characterisation**
- **Digitalisation and Interoperability including Materials Commons**
- **Software development, deployment, and maintenance**
- **Adoption in industrial ecosystems**
- **Sustainability**
- **Policy**

[Registration](#)
[Programme](#)
[Poster Contribution](#)
[Sponsoring & Exhibition](#)

Previous EMMC International Workshops had more than a third of participants coming from industry, benefitting from the opportunity to get a high-level overview of key trends.

Plenary Talks

- Ekin Dogus Cubuk (Google DeepMind, USA)
- Chiara Pernechele (Dallara Automobili, Italy)
- Masahiko Demura (NIMS, Japan)
- Thierry Deutch (CEA, France)
- Eva-Kathrin Schillinger (IAM-I, Belgium)
- David Rouquie (ECETOC, Belgium)

Student reduction

A limited number of reduced rate registrations are available for PhD students submitting a poster.

[Read more ...](#)

Call for posters

During EMMC 2025 you will have the opportunity to network and discuss with your peers. Use the possibility of a poster contribution by presenting scientific results, your organisation, or European projects.

Scientific poster contributions to be considered for **flash talk** if submitted **by 28 February**.

[Read more ...](#)

Prizes for best scientific posters will be awarded.

All accepted abstracts will be published within the EMMC 2025 Proceedings on Zenodo.

EMMC 2025 – Side Events – free of charge

